A Complete Bibliography of Publications in *Technometrics* for the decade 1960–1969

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Title word cross-reference

2 [DT68]. 2^{17-9} [Add65, Pre66]. 2^{k-p} [BH61a, BH61b]. 2^n [Add61, Coo68, Mar69b]. 2^{n-1} [Joh66a]. $2^n 3^m$ [Mar69a, Mar69b]. 2^{p-q} [DW66a]. $2\hat{I}$ [Ku63b]. 2×2 [Owe65c, Owe66a]. 2×3 [BN63, BN64]. $3(2^{n-k})$ [Joh64a]. 32 [Add65]. 3^{4n+1} [Rag65]. 50 [Har66]. ^{3} [CHDF67, Kao69]. ^{m} [Mar67, Mar68b]. ^{n} [Mar67, Mar68b, Rec67]. χ^2 [JB61]. $D_{mn}(n \leq m \leq 20)$ [Zel62a]. $E(y) = \alpha + \delta x + \beta\rho^x$ [SK65]. F [Fox63, Web68c]. k [Bar67b]. $\lambda(r, n)$ [Wil65]. m [HM65b]. N [Ano65i, WW64]. $n = 26$ [Wil65]. s [Har66]. $s = 1$ [Har66]. t [DT68, GB65, Hal63, Kra66b, Owe68]. T^2 [JB61]. U [Sho67b]. V [Add65, Pre66]. $V_1^{(s)}$ [Har66]. W [SW68].

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4 [Luk64b].

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